



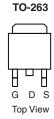
N-Channel 40-V (D-S) 175 °C MOSFET

PRODUCT SUMMARY					
V _{(BR)DSS} (V)	$r_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
40	0.0053 at V _{GS} = 10 V	110	95		

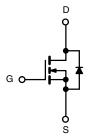
FEATURES

- TrenchFET® Power MOSFET
- 175 °C Junction Temperature
- High Threshold Voltage at High Temperature





Ordering Information: SUM110N04-05H-E3 (Lead (Pb)-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T_C :	= 25 °C, unless other	wise noted		_	
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V _{GS}	20		
Continuous Drain Current (T _{.I} = 175 °C)	T _C = 25 °C		110		
Continuous Diairi Curient (1) = 173 O)	T _C = 125 °C	I _D	70		
Pulsed Drain Current		I _{DM}	300	A	
Avalanche Current		I _{AR}	50		
Repetitive Avalanche Energy ^a	L = 0.1 mH	E _{AR}	125	mJ	
Maximum Power Dissipation ^a	T _C = 25 °C	Б	150 ^b	\A/	
	T _A = 25 °C ^c	P _D	3.75	W	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Limit	Unit	
Junction-to-Ambient	PCB Mount ^c	R _{thJA}	40	°C/W	
Junction-to-Case		R _{thJC}	1	C/VV	

Notes:

- a. Duty cycle \leq 1 %.
- b. See SOA curve for voltage derating.
- c. When Mounted on 1" square PCB (FR-4 material).

SUM110N04-05H

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SPECIFICATIONS $T_J = 25^{\circ}$	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	Cymbol	Test conditions	1411111	1,76.	mux.	Oiiit	
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$ $V_{DS} = 0 \text{ V, } I_D = 250 \mu\text{A}$ 40						
Gate-Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	3.4	3.8	5.0	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current		V _{DS} = 40 V, V _{GS} = 0 V			1		
	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V, T _J = 125 °C			50	μΑ	
		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 175 °C			250		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = 5 \text{ V}, V_{GS} = 10 \text{ V}$	120			Α	
Drain-Source On-State Resistance ^a		V _{GS} = 10 V, I _D = 30 A		0.0044	0.0053	Ω	
	r _{DS(on)}	V _{GS} = 10 V, I _D = 30 A, T _J = 125 °C			0.008		
		V _{GS} = 10 V, I _D = 30 A, T _J = 175 °C			0.0106		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A	20	50		S	
Dynamic ^b	•			•			
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz		6700		pF	
Output Capacitance	C _{oss}			600			
Reverse Transfer Capacitance	C _{rss}			320			
Total Gate Charge ^c	Q_g			95		nC	
Gate-Source Charge ^c	Q_{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$		37			
Gate-Drain Charge ^c	Q_{gd}			21			
Gate Resistance	R_{g}	f = 1.0 MHz		1.7		Ω	
Turn-On Delay Time ^c	t _{d(on)}			20	30		
Rise Time ^c	t _r	$V_{DD} = 20 \text{ V, R}_{L} = 0.4 \Omega$ $I_{D} \cong 50 \text{ A, V}_{GEN} = 10 \text{ V, R}_{g} = 2.5 \Omega$		95	145	ns	
Turn-Off Delay Time ^c	t _{d(off)}			50	75		
Fall Time ^c	t _f			12	20		
Source-Drain Diode Ratings and Cha	aracteristics 7	C _C = 25 °C ^b			<u>. </u>		
Continuous Current	I _S				100	۸	
Pulsed Current	I _{SM}				300	_ A	
Forward Voltage ^a	V_{SD}	I _F = 30 A, V _{GS} = 0 V		0.90	1.50	V	
Reverse Recovery Time	t _{rr}	I _F = 30 A, di/dt = 100 A/μs		40	60	ns	

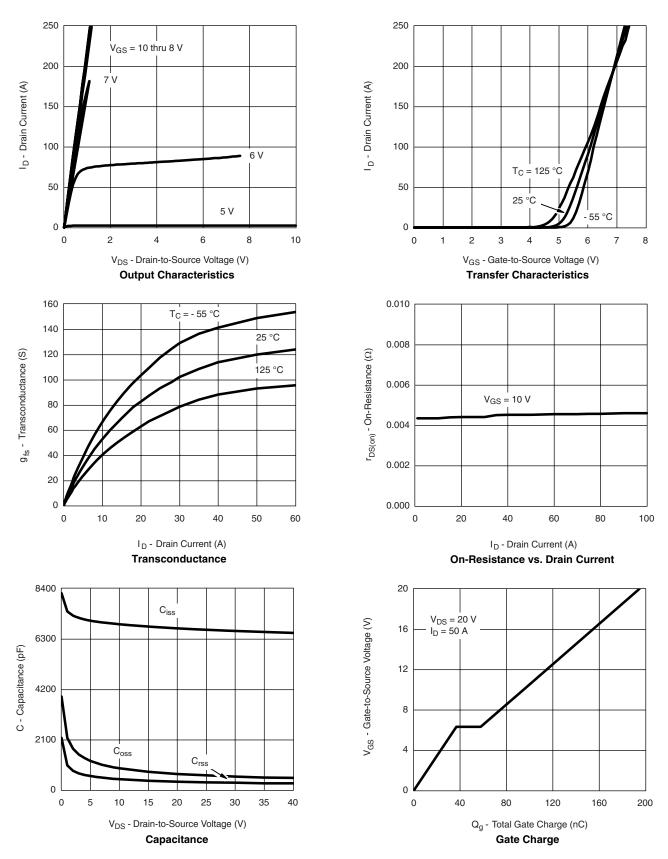
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



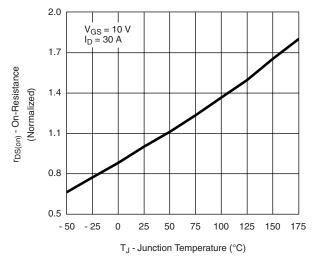
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



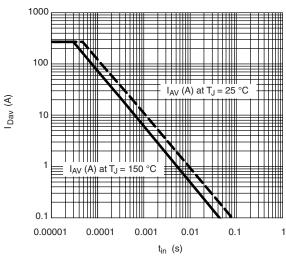
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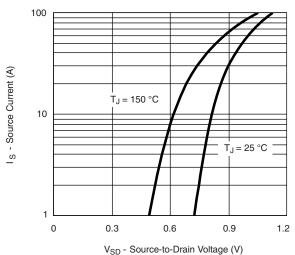
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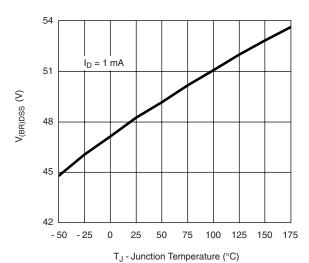
On-Resistance vs. Junction Temperature



Avalanche Current vs. Time



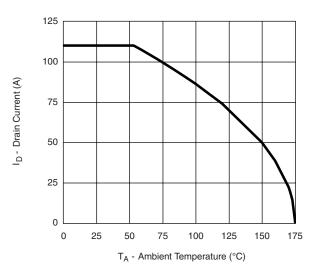
Source-Drain Diode Forward Voltage



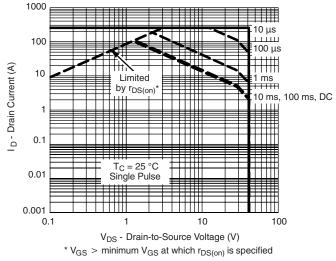
Drain Source Breakdown vs.
Junction Temperature



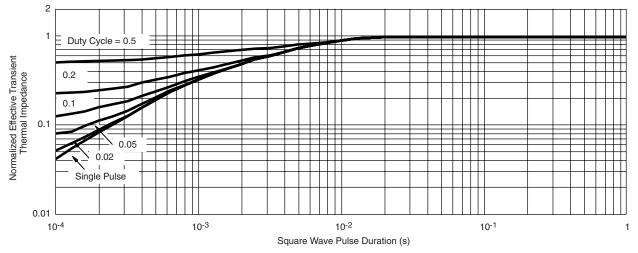
THERMAL RATINGS



Maximum Avalanche and Drain Current vs. Case Temperature



Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case

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